

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		09/988,527	MAO, JEAN-PIERRE	
Examiner		Art Unit		Page 1 of 1
Gregory B. Sefcheck		2662		

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0027919 A1	03-2002	Eneroth et al.	370/395.1
*	B	US-6,717,955 B1	04-2004	Holler, Jan	370/474
*	C	US-6,707,819 B1	03-2004	Fraser et al.	370/395.1
*	D	US-6,704,315 B1	03-2004	Basset-Bathias, Claire	370/395.4
*	E	US-6,526,046 B1	02-2003	Carew, A. J. Paul	370/352
*	F	US-6,075,798 A	06-2000	Lyons et al.	370/474
*	G	US-6,014,381 A	01-2000	Troxel et al.	370/395.52
*	H	US-5,844,906 A	12-1998	Khelghatti et al.	370/474
*	I	US-5,740,173 A	04-1998	Fiorini, Paolo	370/394
*	J	US-5,509,007 A	04-1996	Takashima et al.	370/391
*	K	US-5,327,421 A	07-1994	Hiller et al.	370/395.61
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.